SHIGA7.032APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hojo et al.

Appl. No. : 10/554,380

Filed : October 26, 2005

For : POSITIVE PHOTORESIST

COMPOSITION AND METHOD

FOR FORMING RESIST

PATTERN

Examiner : A. Eoff Group Art Unit : 1753 OK TO ENTER: /A.E./

04/22/2008

## AMENDMENT AND RESPONSE TO FINAL OFFICE ACTION

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed January 11, 2008, Applicants respectfully request the Examiner to enter the following amendments and consider the following remarks.

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 5 of this paper.